

Historical Data Since **Since 1947** IEEE International Frequency Control Symposium (**IFCS**) Conferences and Time Curves of the 2008 IEEE IUS for Future Conference Planning

Note

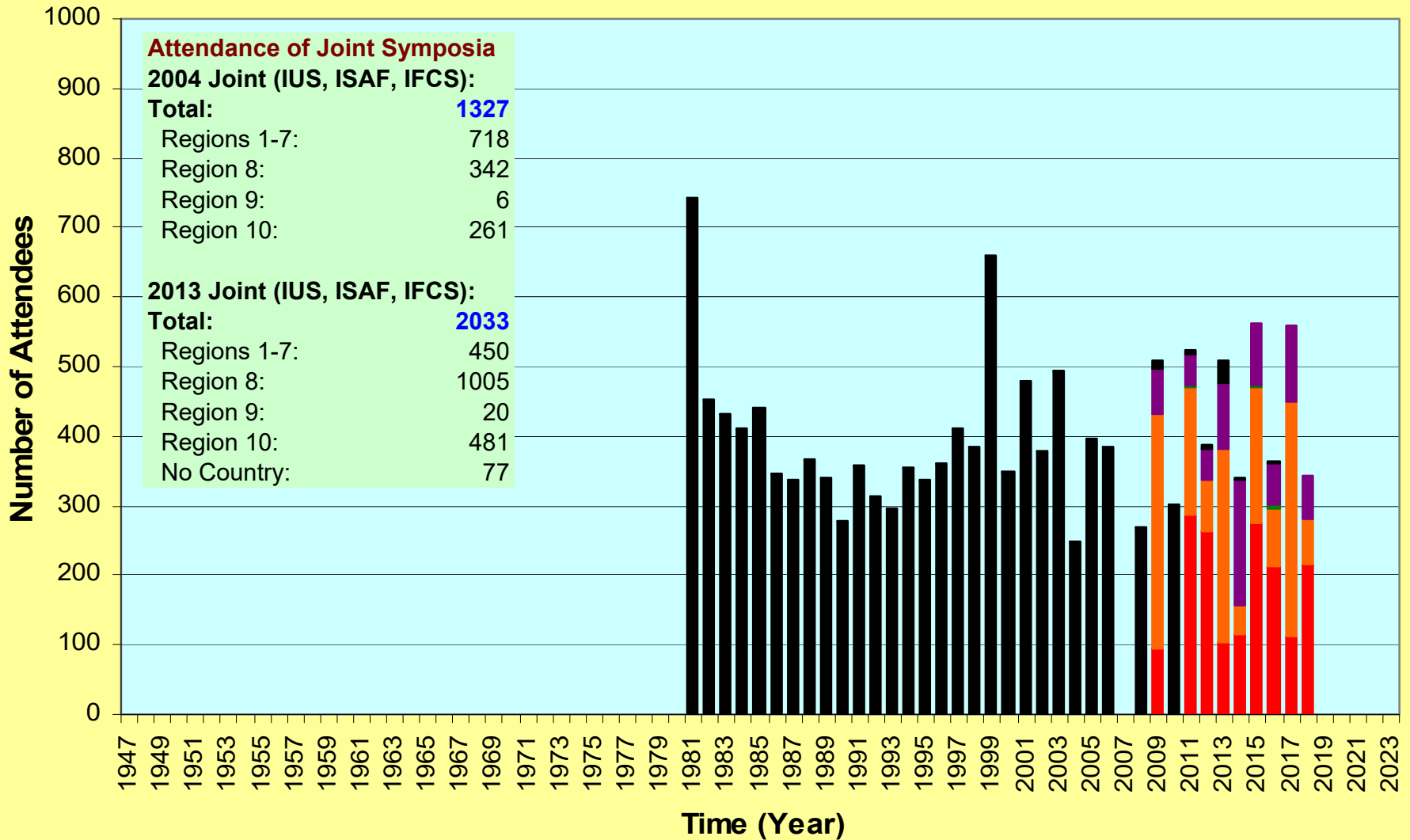
These charts are based on data in the spreadsheet: "[01_0_oper_ius2008_plots_ifcs.xls](#)". Comments in the .xls spreadsheet indicate where the data were obtained. The data were collected from various reports and from some individuals. However, they are far from perfect. There are many missing data. There may be inconsistencies such as the number of abstracts accepted is more than submitted or less than the number of conference proceedings papers published in some years. These data are what I have so far and many of the original data might have already been permanently lost.

This underscores the importance that, to collect conference historical data, each conference should fill out the standard data collection form "[00_uffcs_conf_data_collection_fillable.pdf](#)" soon after the conference while the memory of the conference is still fresh.

Currently, among the three annual UFFC-S conferences, historical data of IEEE IUS are relatively complete and consistent. Thank you all for those who made reports or who provided the data.

of Attendees of the IEEE International Frequency Control Symposia (IFCS) by IEEE Regions (Since 1947) - "0" values mean that data are not available for those years

■ IEEE R1-7 (US/Canada)
 ■ IEEE R8 (Europe/MiddleEast/Africa)
 ■ IEEE R9 (LatinAmerica)
 ■ IEEE R10 (Asia/Pacific)
 ■ No Country

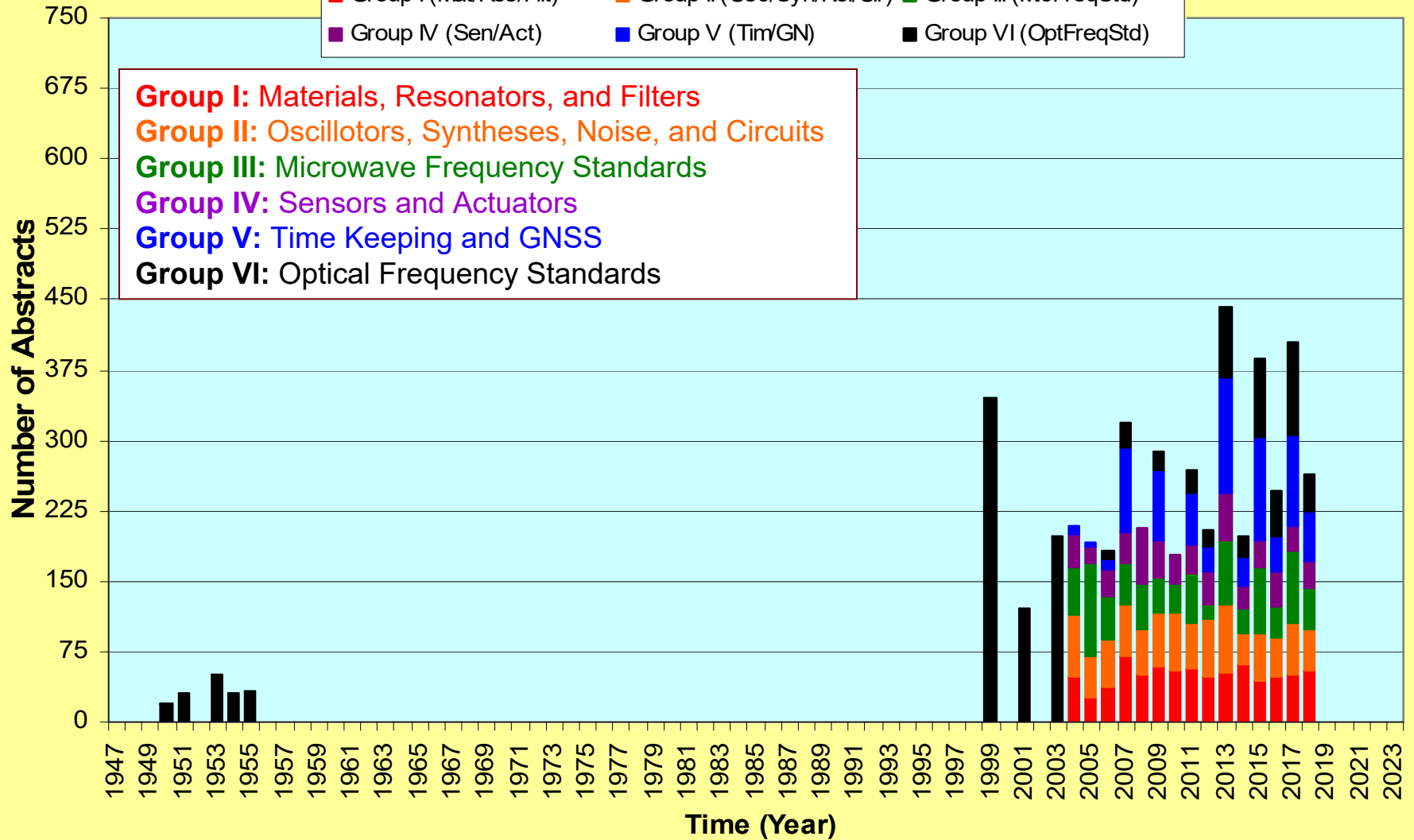


of Abstracts Submitted to the IEEE International Frequency Control Symposia (IFCS) by Each Group (Since 1947)

- "0" values mean that data are not available for those years; "Solid Bar" means no Group data

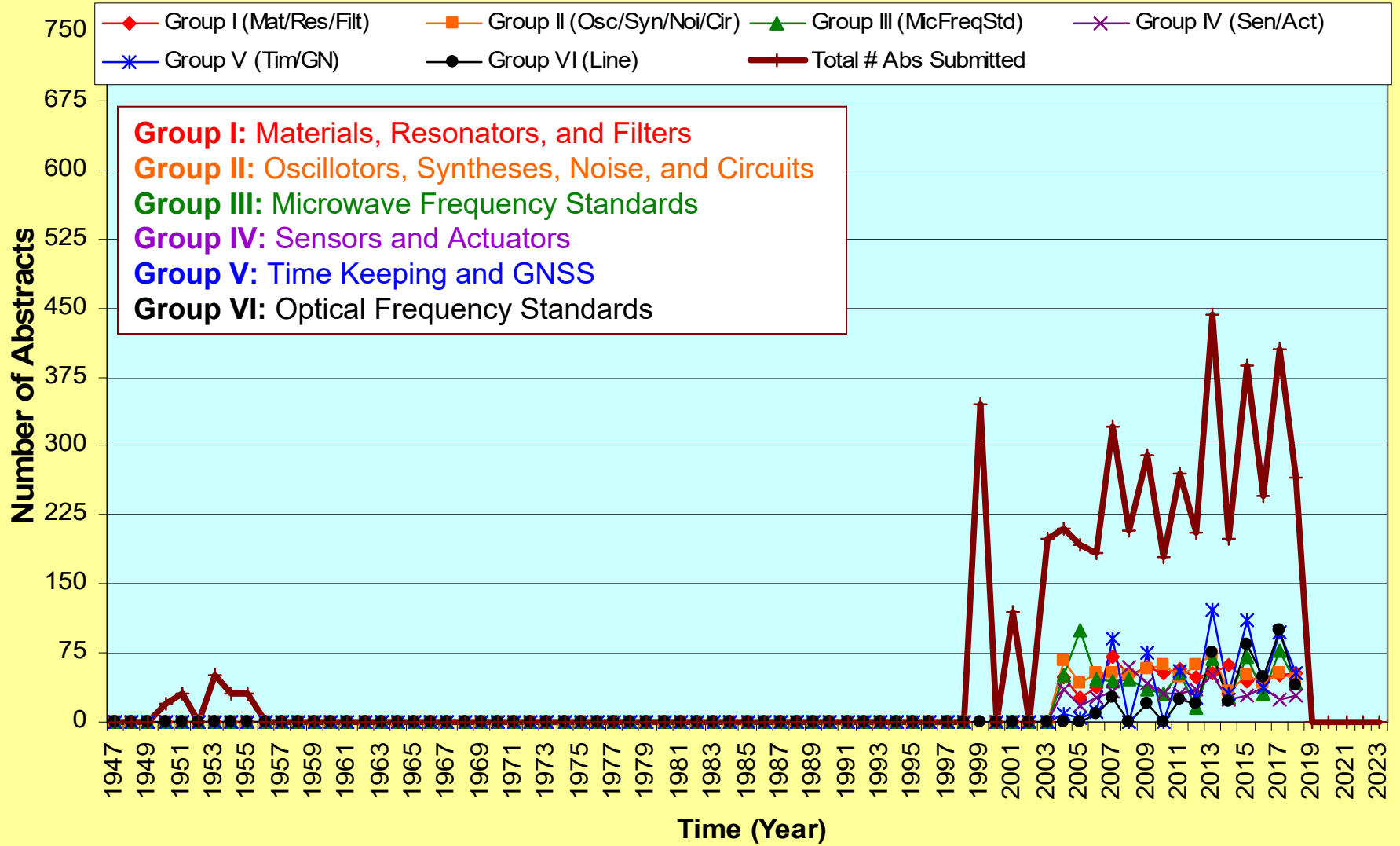
- Group I (Mat/Res/Filt)
- Group II (Osc/Syn/Noi/Cir)
- Group III (MicFreqStd)
- Group IV (Sen/Act)
- Group V (Tim/GN)
- Group VI (OptFreqStd)

Group I: Materials, Resonators, and Filters
Group II: Oscillators, Syntheses, Noise, and Circuits
Group III: Microwave Frequency Standards
Group IV: Sensors and Actuators
Group V: Time Keeping and GNSS
Group VI: Optical Frequency Standards



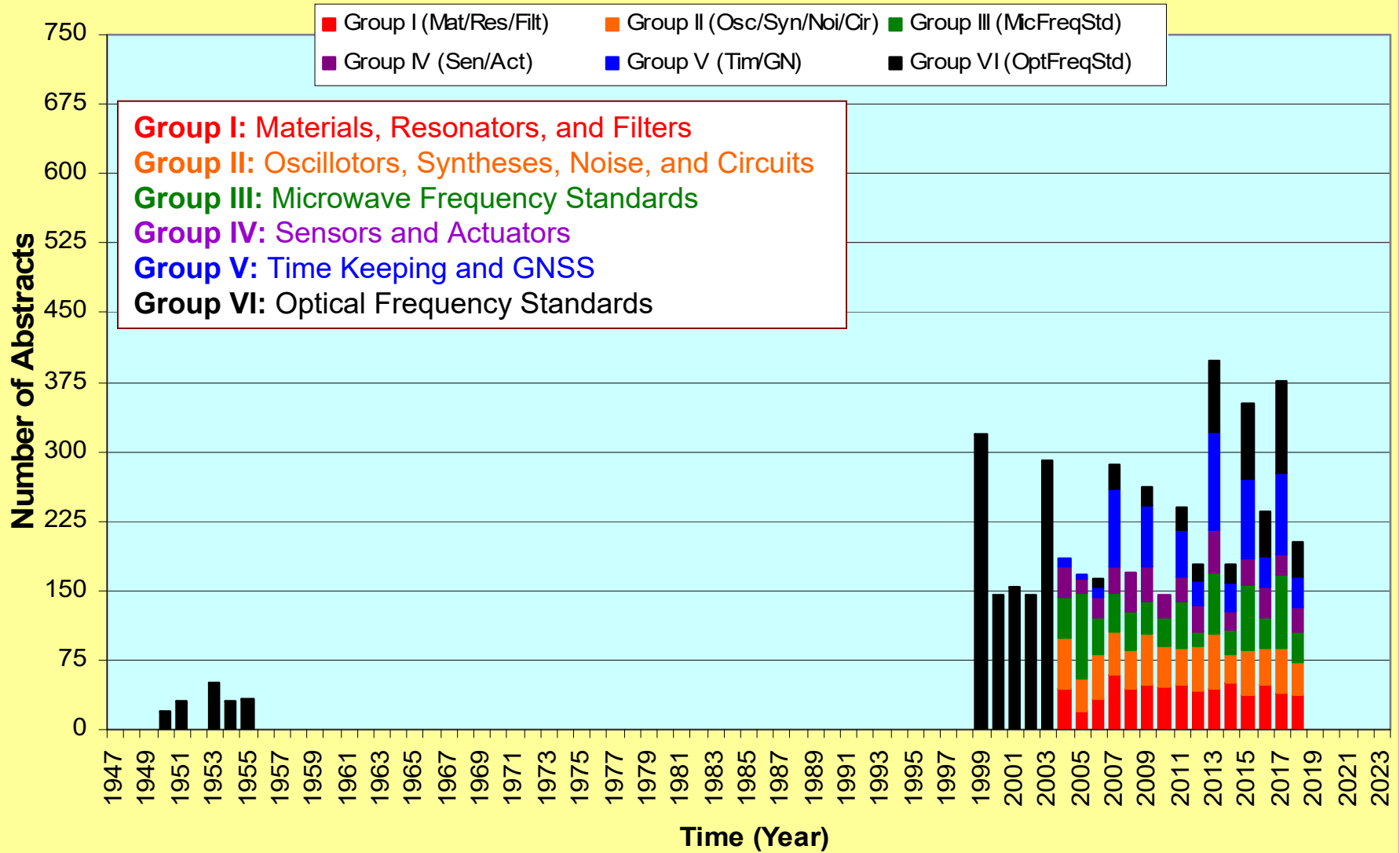
of Abstracts Submitted to the IEEE International Frequency Control Symposia (IFCS) by Each Group (Since 1947)

- "0" values mean that data are not available for those years



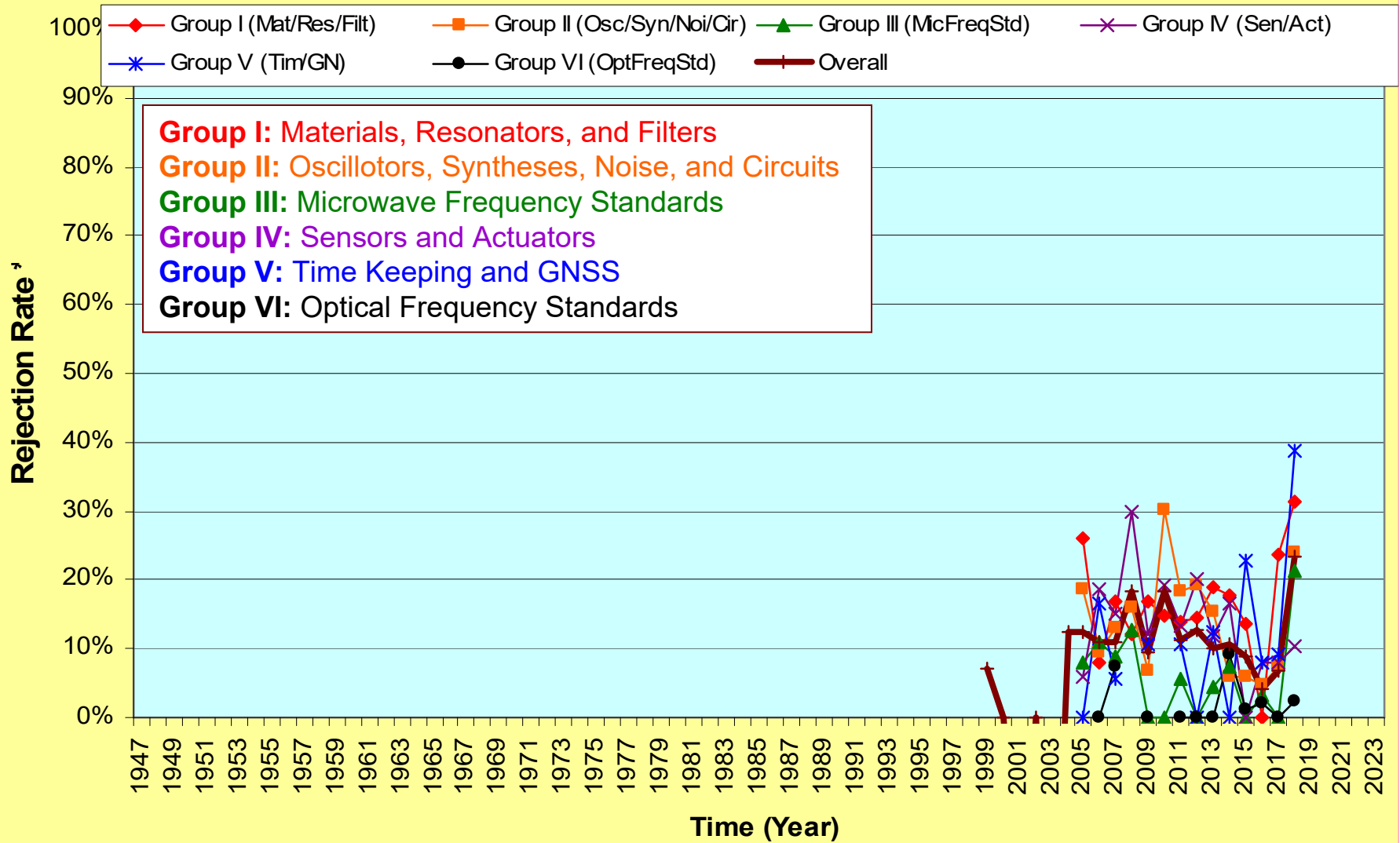
of Abstracts Accepted for the IEEE International Frequency Control Symposia (IFCS) by Each Group (Since 1947)

- "0" values mean that data are not available for those years; "Solid Bar" means no Group data



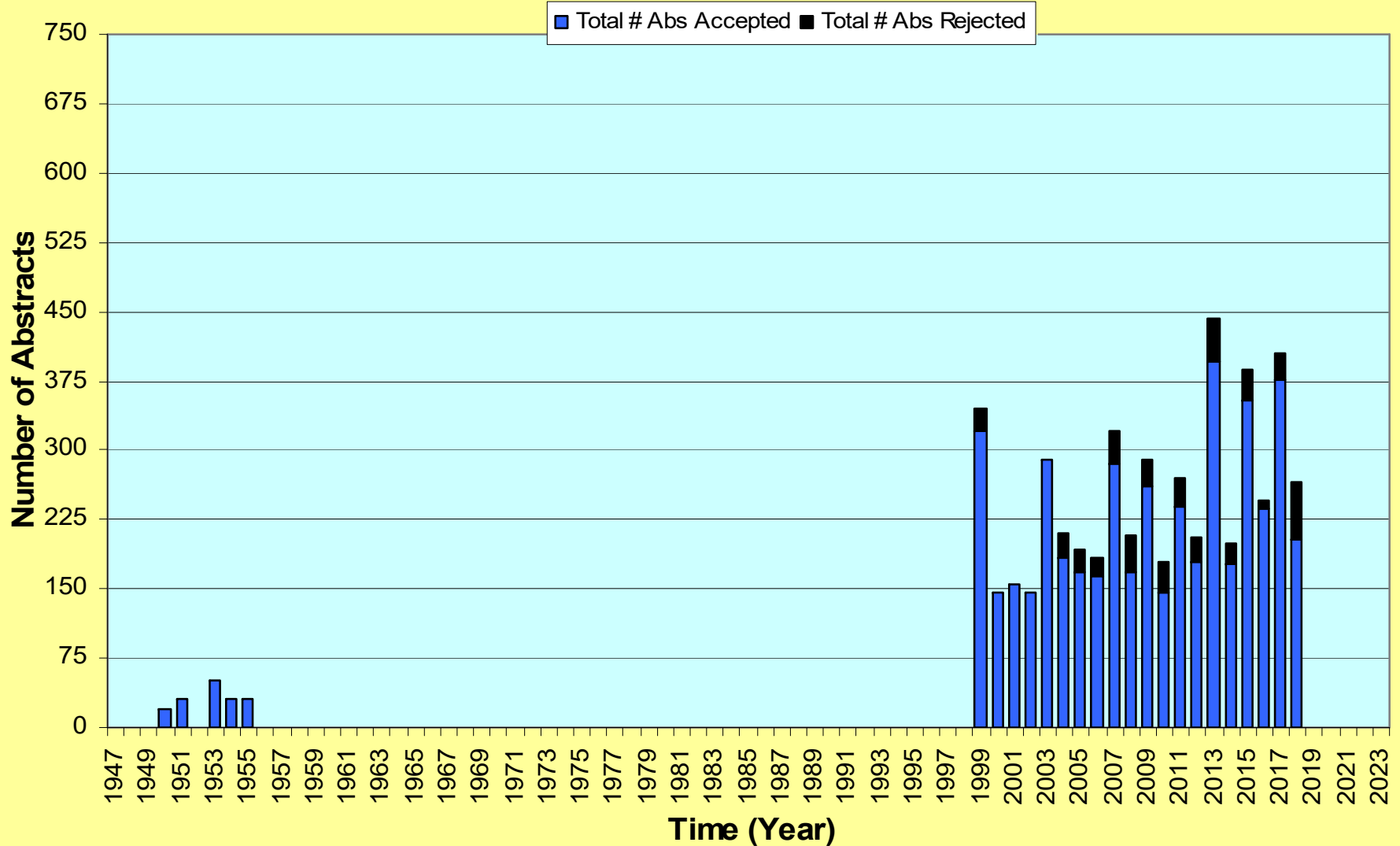
Rejection Rate (%) of the IEEE International Frequency Control Symposia (IFCS) by Each Group (Since 1947)

- "0" values mean that data are not available for those years



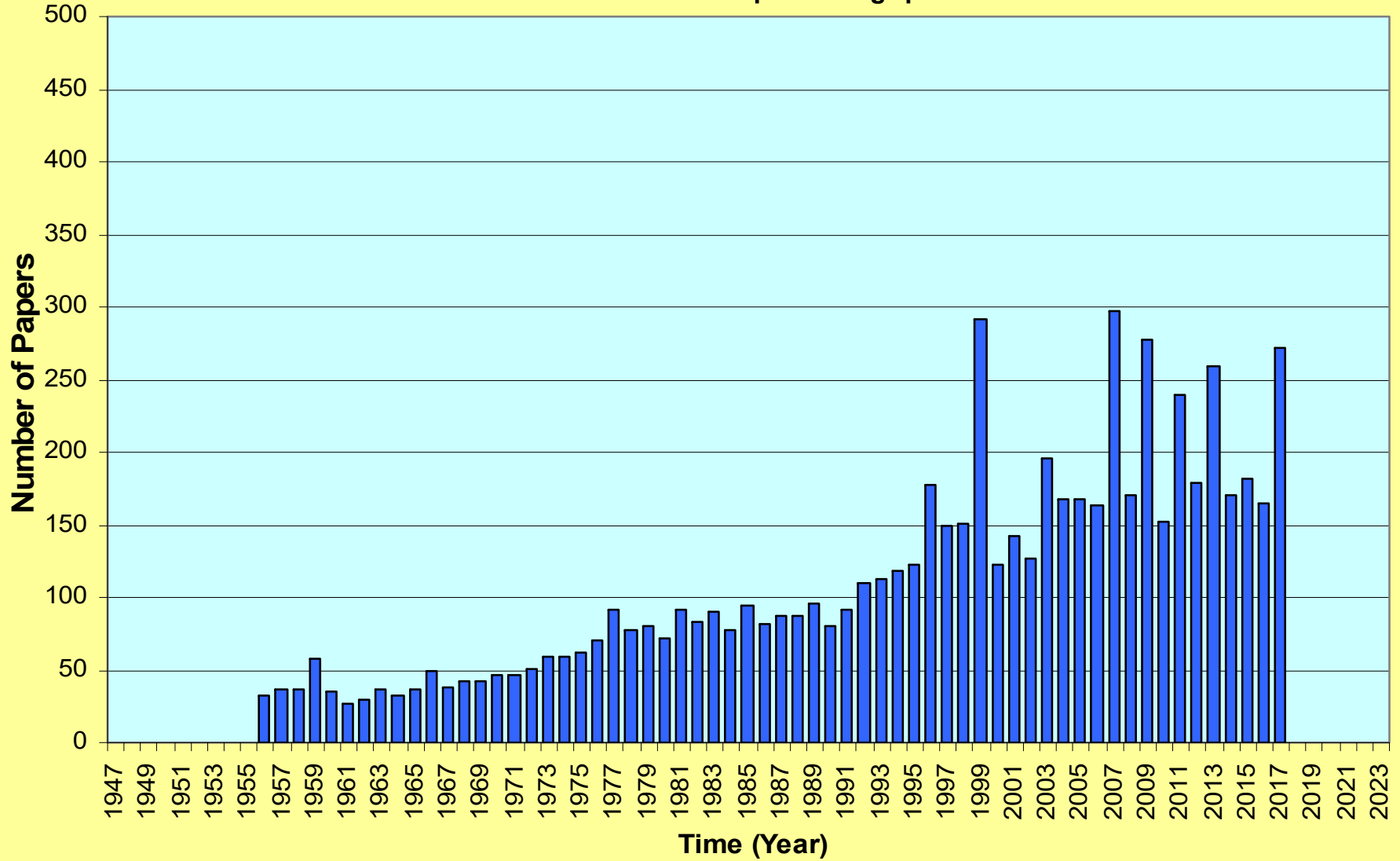
of Abstracts Accepted vs Rejected by the IEEE International Frequency Control Symposia (IFCS) (Since 1947)

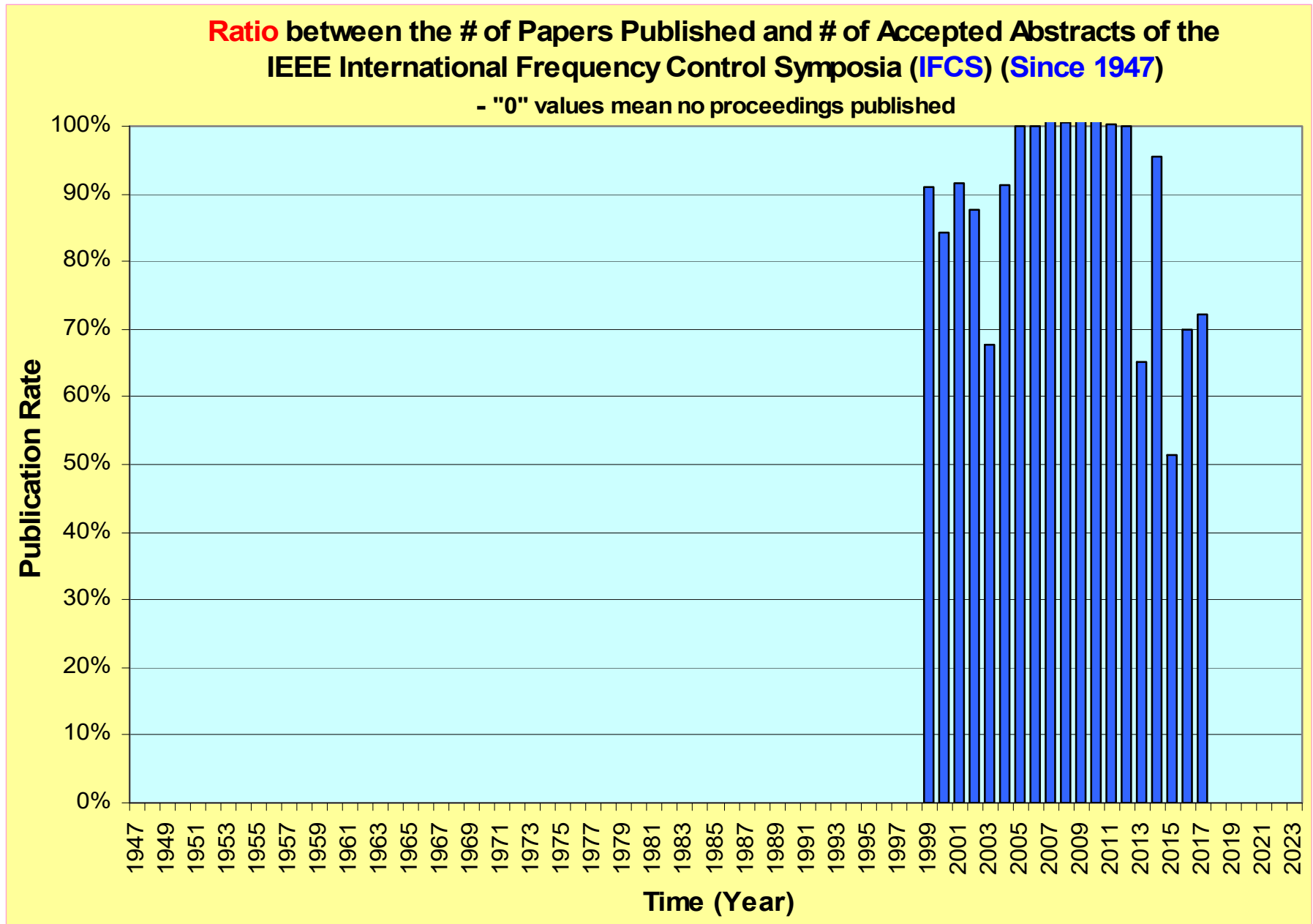
- "0" means that the rejection data are not available for those years



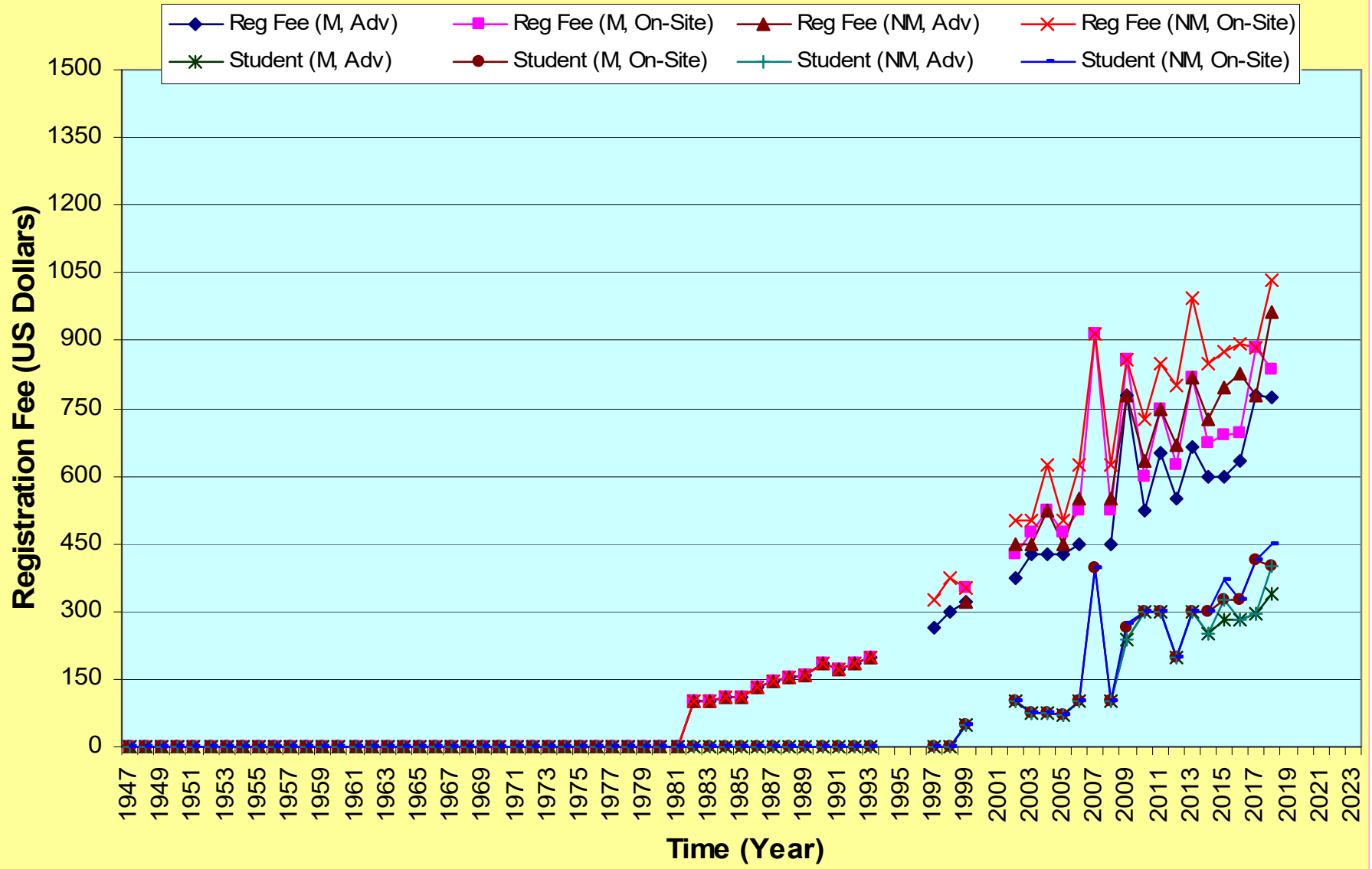
of Papers Published in the Proceedings of the IEEE International Frequency Control Symposia (IFCS) (Since 1947)

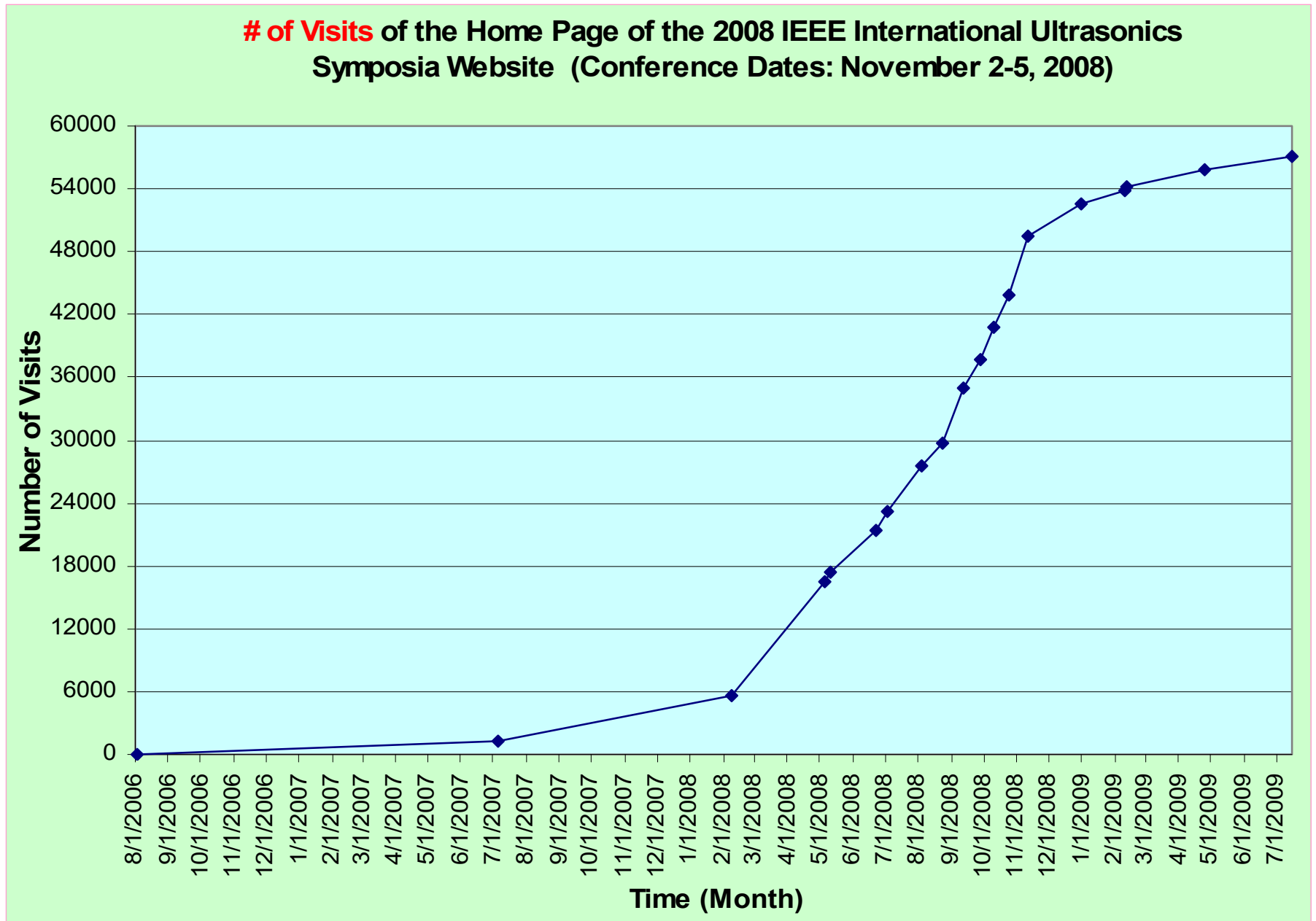
- "0" values mean no proceedings published



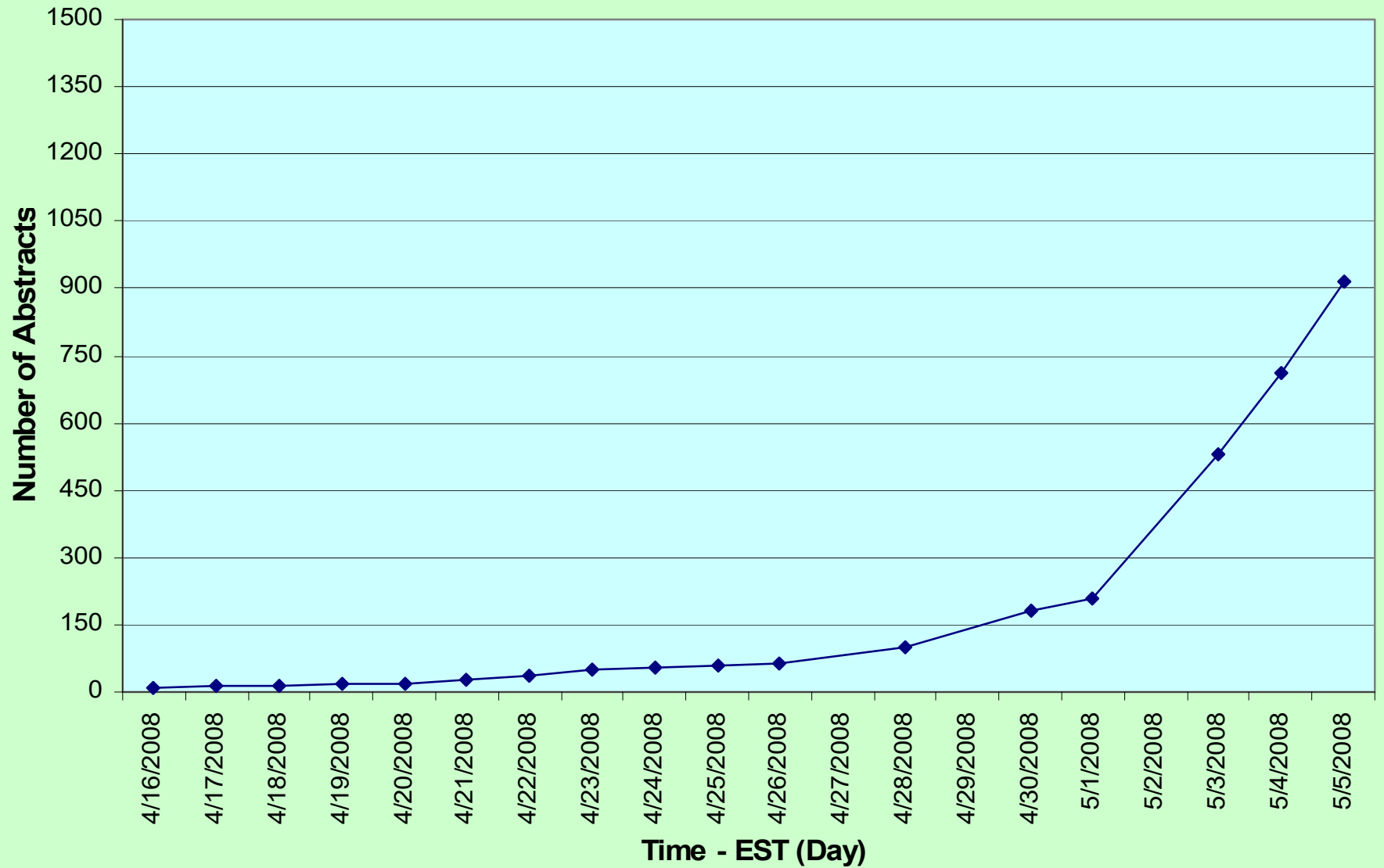


Registration Fees of the IEEE International Frequency Control Symposia (IFCS) (Since 1947) - "0" values mean that data are not available for those years

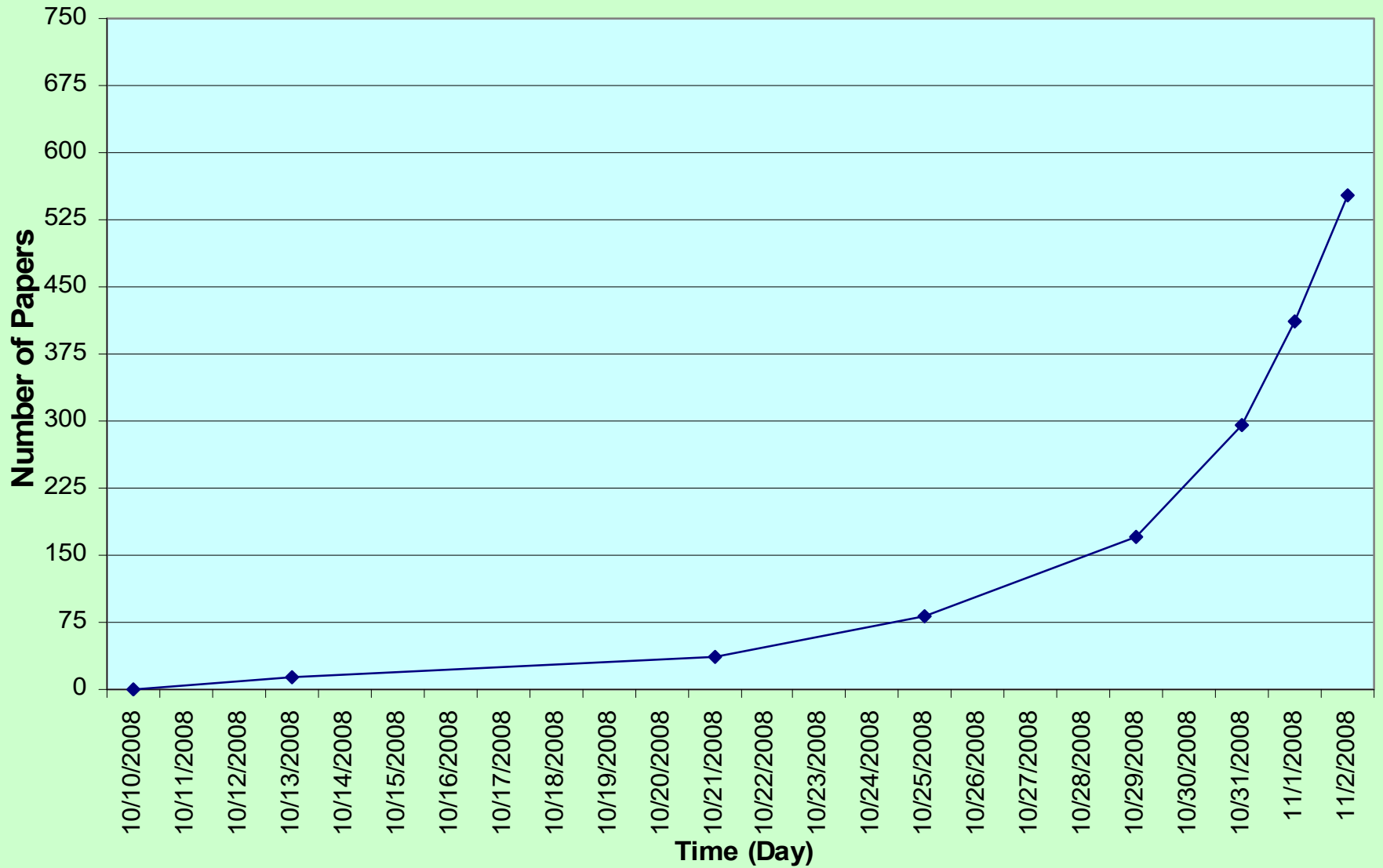




of Abstracts Successfully Submitted to the 2008 IEEE International Ultrasonics Symposium (Submission Deadline: May 4, 2008, PST / May 5, EST)



of Papers Submitted Successfully to the 2008 IEEE International Ultrasonics Symposium (Submission Deadline: Nov. 2, 2008, Beijing Time)



of Short Course Registrations of the 2008 IEEE International Ultrasonics Symposium (Early Registration Opened on July 20, 2008) (Conference Dates: November 2-5, 2008)



of Conference Registrations of the 2008 IEEE International Ultrasonics Symposium (Conference Dates: November 2-5, 2008)

